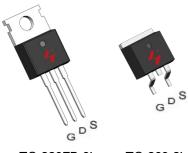


#### N-Channel Enhancement Mode MOSFET

#### **Feature**

- 200V/36A
   R<sub>DS(ON)</sub>=57mΩ(typ.)@VGS = 10V
- 100% Avalanche Tested
- Reliable and Rugged
- Lead-Free and Green Devices Available (RoHS Compliant)

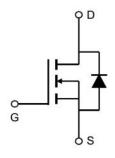
### **Pin Description**



TO-220FB-3L TO-263-2L

### **Applications**

- Power Switching application
- Uninterruptible Power Supply



N-Channel MOSFET

## **Ordering and Marking Information**





Package Code

P:TO-220FB-3L

B:TO-263-2L

Date Code YYXXX WW

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Unit	
Common Rat	tings (Tc=25°C Unless Otherwise Noted)			
VDSS	Drain-Source Voltage		200	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode)	Tc=25°C	36	Α
Mounted on	Large Heat Sink			
lом	Pulsed Drain Current *	Tc=25°C	150	А
	Continuous Danie Coment	Tc=25°C	36	А
lo	Continuous Drain Current	Tc=100°C	25	А
Б.	Manipus Barra Biratinatian	Tc=25°C	180	W
Po	Maximum Power Dissipation	Tc=100°C	90	W
$R_{\theta}$ JC	Thermal Resistance, Junction-to-Case		0.83	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	**	62	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	273	mJ

Note: \* Repetitive rating; pulse width limited by max. junction temperature.

\*\* Surface mounted on FR-4 board.

\*\*\* Limited by TJmax , starting TJ=25 $^{\circ}$ C, L = 0.3mH, VDS=100V, VGS =10V.

## Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Cumbal	Dougranton	Toot Conditions	HY1420			I Imit
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Characteristics						
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>DS</sub> =250μA	200	-	_	V
l	Drain to Source Leekage Current	V <sub>DS</sub> =200V,V <sub>GS</sub> =0V	-	-	1.0	μA
I <sub>DSS</sub> Drain-to-Source Leakage Current	T <sub>J</sub> =125°C	-	-	50	μA	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	3.0	3.8	5.0	V
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V <sub>GS</sub> =10V,I <sub>DS</sub> =30A	-	57	68	mΩ
Diode Cha	racteristics					
V <sub>SD</sub> *	Diode Forward Voltage	IsD=30A,VGS=0V	-	0.85	1.3	V
trr	Reverse Recovery Time	Isp=30A,dIsp/dt=100A/µs	-	48	-	ns
Qrr	Reverse Recovery Charge	ISD-30A, UISD/UI- TOUA/µS	-	78	-	nC

# HY1420P/B



# Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Downwater	Took Conditions		HY1420		11:4
Symbol	Parameter	Test Conditions		Тур.	Max	Unit
Dynamic	Characteristics	·	·		•	
R <sub>G</sub>	Gate Resistance	$V_{GS}$ =0V, $V_{DS}$ =0V,F=1 MHz	-	2.6	-	Ω
Ciss	Input Capacitance	V <sub>G</sub> S=0V,	-	2444	-	
Coss	Output Capacitance	V <sub>DS</sub> =25V,	-	129	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	24	-	
td(ON)	Turn-on Delay Time		-	30	-	
Tr	Turn-on Rise Time	$V_{DD}$ =100 $V$ , $R_{G}$ =2.5 $\Omega$ ,	-	20	-	
td(OFF)	Turn-off Delay Time	IDS=30A,VGS=10V	-	21	-	ns
Tf	Turn-off Fall Time		-	31	-	
Gate Cha	rge Characteristics				•	
Qg	Total Gate Charge	\/ 400\/ \/ -40\/	-	53	_	
Qgs	Gate-Source Charge	$V_{DS}100V, V_{GS}=10V,$ $I_{D}=20A$	-	11	_	nC
Qgd	Gate-Drain Charge	1D-20A	-	16.5	_	

Note: \*Pulse test, pulse width  $\leq 300$ us, duty cycle  $\leq 2\%$ 



# **Typical Operating Characteristics**

**Figure 1: Power Dissipation** 

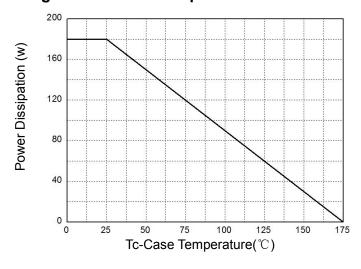


Figure 2: Drain Current

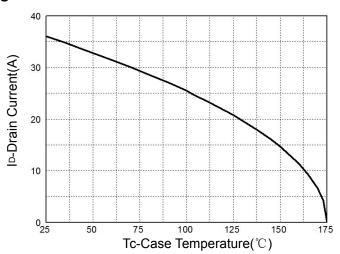
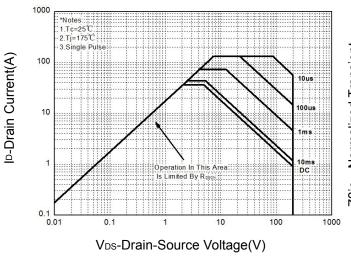
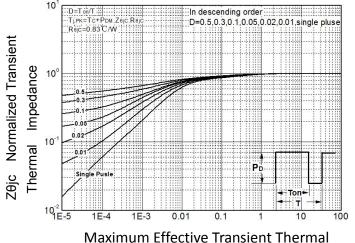


Figure 3: Safe Operation Area



**Figure 4: Thermal Transient Impedance** 



Impedance, Junction-to-Case

**Figure 5: Output Characteristics** 

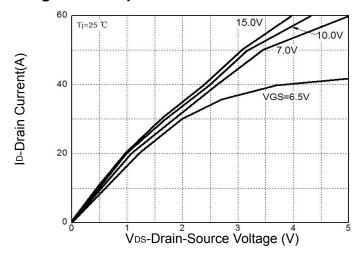
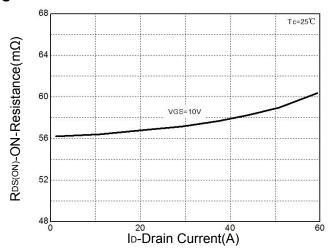


Figure 6: Drain-Source On Resistance





## **Typical Operating Characteristics(Cont.)**

Figure 7: On-Resistance vs. Temperature

2.4

2.0

Rdson@T|=25 ℃:57mΩ

2.0

1.6

VGS=10V |DS=30A

1.2

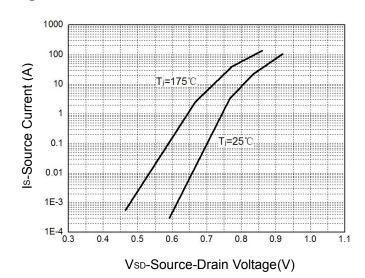
0.8

0.4

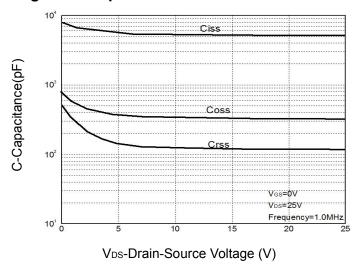
0 25 50 75 100 125 150 175

Tj-Junction Temperature (°C)

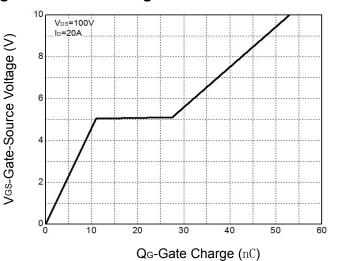
Figure 8: Source-Drain Diode Forward



**Figure 9: Capacitance Characteristics** 

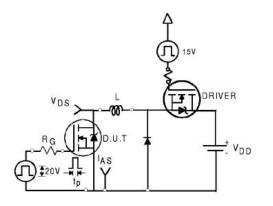


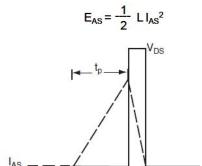
**Figure 10: Gate Charge Characteristics** 



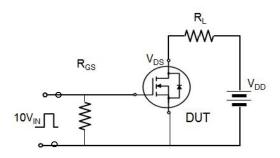


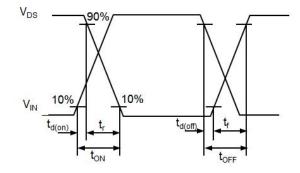
## **Avalanche Test Circuit**



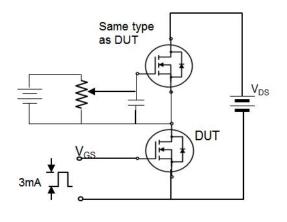


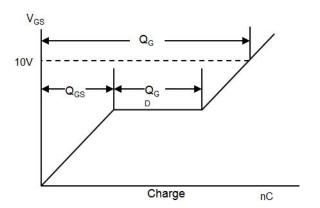
# **Switching Time Test Circuit**





## **Gate Charge Test Circuit**





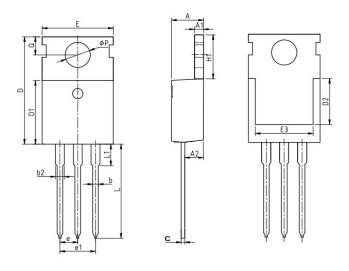


## **Device Per Unit**

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50
TO-263-2L	Tube	50

# Package Information

## TO-220FB-3L



#### **COMMON DIMENSIONS**

SYMBOL		mm	
STIVIBUL	MIN	NOM	MAX
Α	4.37	4.57	4.77
A1	1.25	1.30	1.45
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
С	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	-	-
E	9.70	10.00	10.30
E3	7.00	-	-
е		2.54 BSC	
e1		5.08 BSC	
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	_	3.10	3.40
ФР	3.40	3.60	3.80
Q	2.60	2.80	3.00

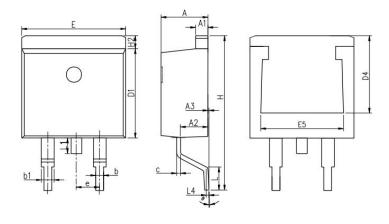


## **Device Per Unit**

Package Type	Unit	Quantity
TO-263-2L	Tube	50

# Package Information

## TO-263-2L

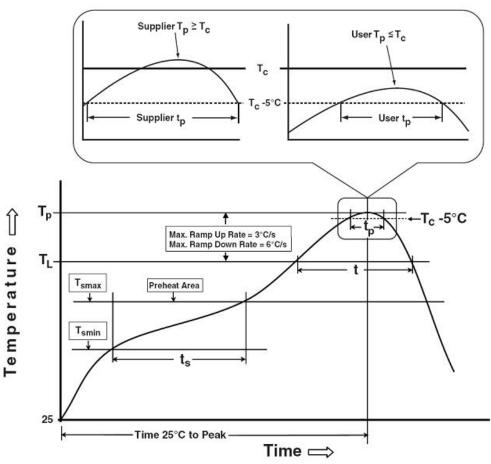


#### **COMMON DIMENSIONS**

SYMBOL		mm	
STIMBUL	MIN	NOM	MAX
А	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0	0.13	0.25
b	0.7	0.81	0.96
b1	1.17	1.27	1.47
С	0.3	0.38	0.53
D1	8.5	8.7	8.9
D4	6.6	-	-
Е	9.86	10.16	10.36
E5	7.06	-	-
е		2.54 BSC	
Н	14.7	15.1	15.5
H2	1.07	1.27	1.47
L	2	2.3	2.6
L1	1.4	1.55	1.7
L4	0.25 BSC		
θ	0°	5°	9°



### **Classification Profile**



### **Classification Reflow Profiles**

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly	
Preheat & Soak	100 °C	150 °C	
Temperature min (T <sub>smin</sub> )	150 °C	200 °C	
Temperature max (T <sub>smax</sub> )	60-120 seconds	60-120 seconds	
Time (Tsmin to Tsmax) (ts)	00-120 Seconds	00-120 seconds	
Average ramp-up rate	3 °C/accord may	3°C/accord may	
(T <sub>smax</sub> to T <sub>P</sub> )	3 °C/second max.	3°C/second max.	
Liquidous temperature (T <sub>L</sub> )	183 °C	217 °C	
Time at liquidous (t₋)	60-150 seconds	60-150 seconds	
Peak package body Temperature	Con Classification Town in table 4	SecClessification Tempin table 2	
(T <sub>p</sub> )*	See Classification Temp in table 1	SeeClassification Tempin table 2	
Time (t <sub>P</sub> )** within 5°C of the specified	20**	20**	
classification temperature (T <sub>c</sub> )	20** seconds	30** seconds	
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.	
Time 25°C to peak temperature	6 minutes max.	8 minutes max.	
*Tolerance for peak profile Temperature (T <sub>0</sub> ) is defined as a supplier minimum and a user maximum.			

Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

<sup>\*\*</sup> Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

## HY1420P/B



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

#### Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

## **Reliability Test Program**

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

#### **Customer Service**

Worldwide Sales and Service: sales@hymexa.com Technical Support: Technology@hymexa.com

Xi'an Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706 FAX: (86-029) 86685705 E-mail: sales@hymexa.com Web net: www.hymexa.com